## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Bernstein et al.

Serial No.: Not Yet Assigned

Group Art Unit: Not Yet Assigned

Filing Date: Concurrently Herewith

Examiner: Unknown

For: SYSTEM AND METHOD FOR TARGET-BASED COMPACT MODELING

Assistant Commissioner of Patents Washington, D.C. 20231

## INFORMATION DISCLOSURE STATEMENT

Sir:

Under the provisions of 37 CFR §1.97 through §1.99 and pursuant to applicants' duty of disclosure under 37 CFR §1.56, applicants respectfully bring the following documents, listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. Copies of the listed documents are provided herewith for the convenience of the Examiner. This citation does not constitute an admission that the references are relevant or material to the claims. They are only cited as constituting related art of which the applicants are aware.

It is respectfully requested that the listed references be considered by the Examiner and formally made of record in this application.

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 09-0456.

Respectfully submitted

Frederick W. Gibb, III Registration No. 37,629

McGinn & Gibb, PLLC 2568-A Riva Road, Suite 304 Annapolis, Maryland 21401 (410) 573-1545 Customer No. 28211

## INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Docket Number (Optional) BUR9=2001=0178=US1	Application Number Not Yet Assigned				
Applicant(s) Bernstein et al.					
Filing Date	Group Art Unit				
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				U.S. PAT	ENT DOCUMENTS				· · · · · ·
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING DATE  IF APPROPRIATE	
		5,438,527	08/01/95	Feldba	umer et al.				<u> </u>
		5,646,870	07/08/97	Krivok	apic et al.			235	
		5,655,110	08/05/97	Krivok	apic et al.				
		5,966,527	10/12/99	Krivok	Krivokapic et al.				
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				FOREIG	N PATENT DOCUMENT	TS			
	REF	DOCUMENT NUMBER DATE		COUNTRY		CLASS	SUBCLASS	Translation YES NO	
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				OTHER	DOCUMENTS (Includ	ding Author, Title, Do	ate, Pertinent Pag	ges, Etc.)	
EXAMINE	R				DATE CONSIDERED				
EXAMINEI	R: Initi	al if citation considered, whether	or not citation is i	n conforman	e with MPEP Section 609	9; Draw line through	citation if not in	1 conforma	nce and

Form PTO-A820

(also form PTO-1449)

not considered. Include copy of this form with next communication to applicant.